34. (Twice Amended) A semiconductor device comprising:

a semiconductor substrate;

a first insulating film formed on said semiconductor substrate;

a first conductor formed on said semiconductor substrate through said first insulating

film;

a first upper wire formed on said first insulating film and said first conductor; and

a second insulating film formed on said first upper wire and over said first insulating

film, said second insulating film including a thin area over said first conductor for guiding a laser

beam;

a second conductor formed on said semiconductor substrate through said first insulating

film below the thin area; and

a second upper wire formed on an extension line of said first upper wire on said first

insulating film and said second conductor beneath said second insulating film.

35. (Amended) A semiconductor device comprising:

a semiconductor substrate;

a first insulating film formed on said semiconductor substrate;

a first conductor formed on said semiconductor substrate through said first insulating

film, including a first portion formed on said semiconductor substrate and a second portion

formed on the first portion made of a different material from that of the first portion;

a first upper wire formed on said first insulating film and said first conductor; and

FINNEGAN HENDERSON FARABOW GARRETT & DUNNERLL

1300 I Street, NW Washington, DC 20005 202.408.4000 Fax 202.408.4400 www.finnegan.com

-2-